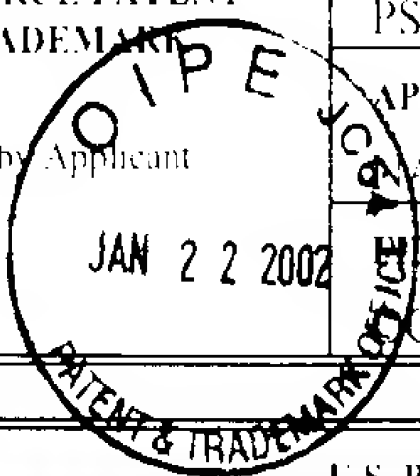


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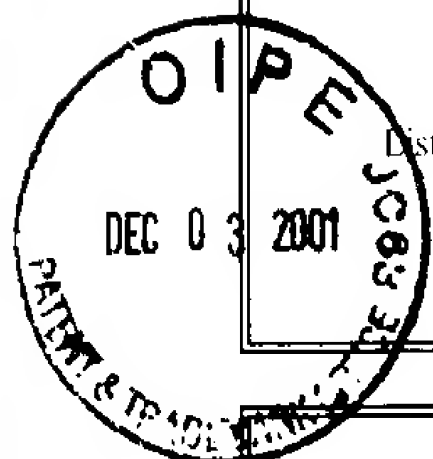


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EXAMINER	Andin Marschlof	
	DATE CONSIDERED	1/2/03
*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

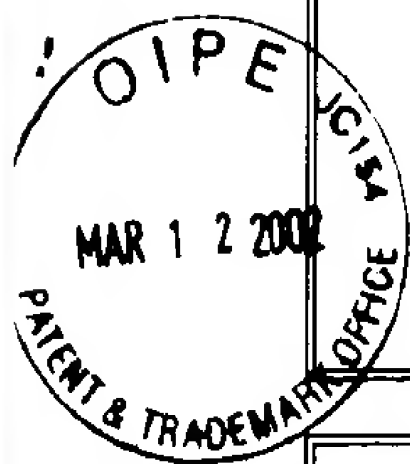


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	FILING DATE OCTOBER 2, 2000	
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AM	AA	4,884,886	12/05/89	Salzman et al.	356	367	
AM	AB	5,674,743	10/07/97	Ulmer	435	287.2	
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EXAMINER	Arden Mancoske	
	DATE CONSIDERED	1/2/03
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		



FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  List of Information Cited by Applicant  Page 1 of 1	ATTY. DOCKET NO. PSY 00 2182B	SERIAL NO. 09/677,198
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	FILING DATE OCTOBER 2, 2000	GROUP 1631 <del>1754</del>

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M	AA	6,334,856	01/01/02	Allen et al.	604	191	
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EXAMINER	<i>Andin Manoles</i>	DATE CONSIDERED <i>1/2/03</i>
*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

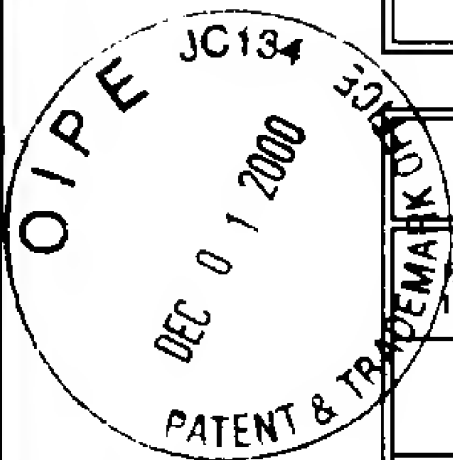
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EXAMINER	Anda Mansel	
	DATE CONSIDERED	1/2/03
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and <u>not</u> considered. Include copy of this form with next communication to applicant.		

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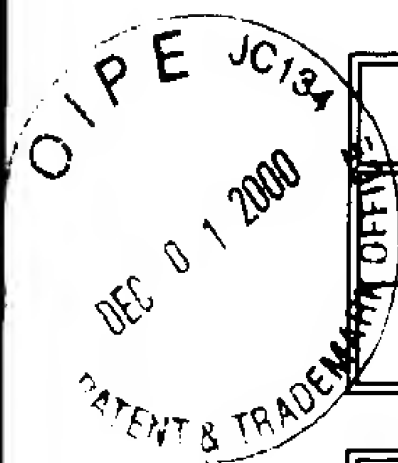


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AM	AA	3 755,730	08/28/73	Vogelgesang	324	34R	
AM	AB	3,878,367	04/15/75	Fayling et al.	235	61.12M	
AM	AC	3 897,284	07/29/75	Livesay	149	21	
AM	AD	4,053,433	10/11/77	Lee	252	408	
AM	AE	4,098,935	07/04/78	Knudsen	428	40	
AM	AF	4,306,993	12/22/81	Danielson et al.	252	316	
AM	AG	4,329,393	05/11/82	La Perre et al.	428	325	
AM	AH	4 390,452	06/28/83	Stevens	252	408.1	
AM	AI	4 397,142	08/09/83	Bingham	57	238	
AM	AJ	4 469,623	09/04/84	Danielson et al.	252	408.1	
AM	AK	4 527,383	07/09/85	Bingham	57	200	
	AL	<del>09/598,395</del>	<del>06/20/00</del>	<del>Natan et al.</del>			
	AM	<del>09/676,890</del>	<del>10/02/00</del>	<del>Natan et al.</del>			
	AN	<del>09/677,203</del>	<del>10/02/00</del>	<del>Natan et al.</del>			

FOREIGN PATENT DOCUMENTS							
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AM	AO	WO 99/18240	04/15/99	PCT, <i>Sorge</i>			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)		
AM	AP	Al-Mawlawi et al. (1994) J. Mater. Res. 9:1014-1018
AM	AO	Bruchez et al. (1998) Science 281:2013-2016
AM	AR	Cepak and Martin (1999) Chem. Mater. 11:1363-1367
EXAMINER	<i>Arden Mawlawi</i>	
	DATE CONSIDERED	1/2/03
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>		

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AM	BE	Cepak et al. (1997) Chem. Mater. 9:1065 -1067
AM	BF	Cepak and Martin (1998) J. Phys. Chem. B 102:9985 - 9990
AM	BG	Davis et al. (1998) Chem. Mater. 10:2516 -2524
AM	BH	El-Kouedi et al. (1998) Chem. Mater. 10:3287 -3289
AM	BI	El Kouedi and Foss, Jr. (2000) J. Phys. Chem. B. 104:4031 -4037
AM	BJ	Martin et al. (1990) J. Am. Chem. Soc 112:8976 -8977
AM	BK	Martin et al. (1999) Adv. Materials 11:1021 -1025
AM	BL	Martin (1996) Chem. Mater. 8:1739 -1746
AM	BM	McDade and Fulton (1997) Medical Device and Diagnostic Industry 19:75 -82
AM	BN	Meng et al. (1998) Solid State Communications 106:215 -219
AM	BO	Merchant and Weinberger (2000) Electrophoresis 2000 21:1164 -1167
AM	BP	Michael et al. (1998) Anal. Chem. 70:1242 -1248
AM	BQ	Piatek et al. (1998) Nature Biotechnology 16:359 -363
AM	BR	van der Zande et al. (1997) J. Phys. Chem. B. 101:852 -854
AM	BS	Wang et al. (1996) Thin Solid Films 288:86 -89
AM	BT	Wong et al. (1996) Chem. Mater. 8:2041 -2046
AM	BU	Zhang et al. (1999) Chem. Mater. 11:1659 -1665
EXAMINER	Andin Masolef	
	DATE CONSIDERED	1/2/03
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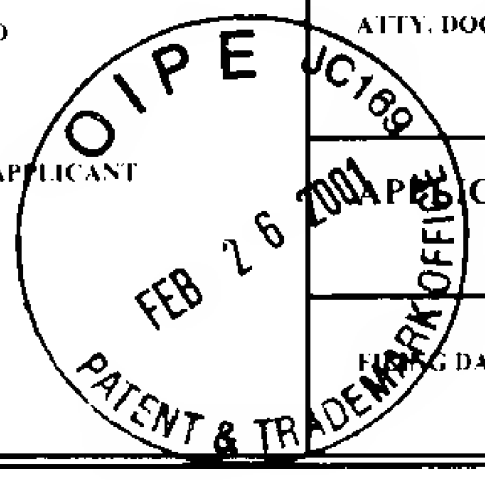
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APPLICANT NATAN ET AL. FILING DATE OCTOBER 2, 2000		
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U.S. PATENT DOCUMENTS						
EXAM. INITIAL		DOCUMENT NUMBER	DATE	NAME	CLS	SUB-CLS
AM	AA	4,679,939	07/14/87	Curry et al.	356	336
AM	AB	4,855,930	08/08/89	Chao et al.	364	497
AM	AC	5,091,188	02/25/92	Haynes <del>et al.</del>	424	450
AM	AD	5,303,710	04/19/94	Bashkansky et al.	128	665
AM	AE	5,449,565	09/12/95	Aoki et al.	428	694BA
AM	AF	5,508,164	04/16/96	Kausch et al.	435	6
AM	AG	5,512,131	04/30/96	Kumar et al.	156	655.1
AM	AH	5,045,019	07/08/97	Erickson et al.	51	309
AM	AI	5,667,667	09/16/97	Southern	205	687
AM	AJ	5,846,517	12/08/98	Unger	424	9.52
AM	AK	5,927,621	07/27/99	Ziolo et al.	241	21
AM	AL	5,985,356	11/16/99	Schultz et al.	427	8
AM	AM	5,997,958	12/07/99	Sato et al.	427	468

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EXAMINER	Andin Marschel	
DATE CONSIDERED	1/2/03	
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AM	BA	6,020,419	02/01/00	Bock et al.	524	590	
AM	BB	6,071,336	06/06/00	Fairchild et al.	106	464	
AM	BC	6,093,302	07/25/00	Montgomery <del>WMA</del>	205	122	
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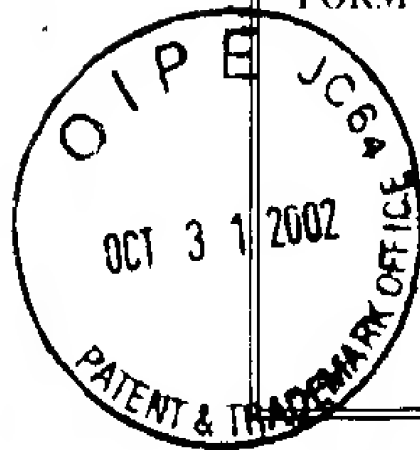
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EXAMINER	Arden Maszley	
	DATE CONSIDERED	1/2/03
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AM	AR	EP 1018365	07/12/00	Europe Kaye et al.	---	---	
AM	AS	WO97/15390	05/01/97	PCT, Kaye et al.	---	---	
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AM	AY	Liu et al. (1995) Physical Review B, 51(11) 7381-7384
AM	AZ	Piroux et al. (1999) J. Mater. Res., 14(7):3042-3050
AM	AAA	Schwarzacher (1999) Electrochemical Society Interface, 20-24
	AAB	
	AAC	
	AAD	

EXAMINER

Andin Marscher

DATE CONSIDERED

1/2/03

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<b>FORM PTO-1449</b> <b>U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</b> List of Information Cited by Applicant Page 1 of 1 <b>Q I P E</b> <b>JUL 23 2002</b> <b>U.S. PATENT &amp; TRADEMARK OFFICE</b>	<b>ATTY. DOCKET NO.</b> PSY 00 2182B	<b>SERIAL NO.</b> 09/677,198
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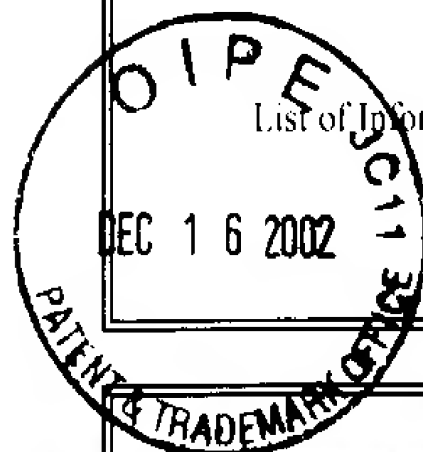
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AM	AB	6,143,211	11/2000	Mathiowitz et al.	264	4	
AM	AC	6,162,532	12/2000	Black et al.	428	323	
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	DATE CONSIDERED	1/2/03
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AM	AN	Al-Rawashdeh et al. (1998) J. Phys. Chem. B 102:361-371
AM	AO	Braun et al., Nature 402 (1999) 603-604
AM	AY	Brumlik et al., J. Am. Chem. Soc. 113 (1991) 3174 - 3175
AM	AQ	Foss et al. (1992) J. Phys. Chem. 96:9001-9007
AM	AR	Foss et al., J. Phys. Chem. 98 (1994) 2963 - 2971
AM	AS	Hornyak et al. (1997) J. Phys. Chem. 101:1548-1555
AM	AT	Hulteen et al., J. Mater. Chem. 7 (1997) 1075 - 1087
AM	AU	Jirage et al. (1997) Science 278:655-658
AM	AV	Martin (1995) Acc. Chem. Res. 28:61-68
AM	AW	Nishizawa et al. (1995) Science 268:700-702
AM	AX	Penner et al. (1987) Anal. Chem. 59:2625-2630
AM	AY	Sandrock et al. <del>1999</del> J. Phys. Chem. B 103:11398-11406 (1999)
	AZ	<del>Turney et al.</del> (1989) J. Phys. Chem. 93:2878-2880 <u>Turney et al.</u>

EXAMINER

*Andin Marschel*

DATE CONSIDERED

1/2/03

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.